**BEST AVAILABLE COPY** PAGE 1 of 1 OMB No. 0651-0011(12/31/86) INFORMATION DISCLOSURE CITATION WITH DOCUMENT COPIES Atty. Docket No. Serial No. Submitted by: DP-308065 10/646551 Applicant SCOTT A. MCBAIN ZHIBO ZHAO Delphi Technologies, Inc. MAR 9 7 2005 Filing Date Group Reg. No. 37181 August 21, 2003 3752 PATENT DOCUMENTS Exam. Document Date Name Class Filing Date Sub Init. Number Class (if approp.) 6464933 10/15/02 Popoola et al 4836447 06/06/89 Browning ı 1 1 ۱ 1 1 1 1 1 FOREIGN PATENT DOCUMENTS Document Date Country Class Subclass Translation Number Yes | No 05/13/92 0484533 |EP ı 1 ۱ OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc. European Search Report dated 12/21/04 ı Examiner DINHQ. NOUYEDPate Considered \*Examiner: Initial if reference considered whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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VV	5,328,751	07/1994	Komorita	a, et al.	1				
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VV)	5,465,627	11/14/1995	Garshelis	3	ı		1		
W/7	5,493,921	02/27/1996	Alasafi		ı		1		****************
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W)	5,525,570	06/11/1996	Chakrabo	orty, et al.	1		ī	<u> </u>	
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Lindsey Dickerson Name:

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W/D	6,119,667	09/19/2000	Boyer, e	t al.					
20 C	)  6,145,387	11/04/2000	Garsheli:	s		1	1		
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2V)	6,189,663	02/20/2001	Smith, et	al.			1		
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W)	6,422,360	07/26/2002	Oliver, et	t al.		l			1
WN	6,424,896B1	07/23/2002	Lin			ı	1		1
AN	6,446,857	09/10/2002	Kent, et a	ai.			ı	1	1
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